

Silicon Carbide Diode

Rev.01 - 07 March 2022

Product data sheet

1. General description

Dual Silicon Carbide Schottky diode in a TO247-3L plastic package, designed for high frequency switched-mode power supplies.

2. Features and benefits

- Highly stable switching performance
- High forward surge capability I_{FSM}
- Extremely fast reverse recovery time
- Superior in efficiency to Silicon Diode alternatives
- Reduced losses in associated MOSFET
- Reduced EMI
- Reduced cooling requirements
- RoHS compliant
- High junction operating temperature capability (T_{i(max)} = 175 °C)

3. Applications

- Power factor correction
- Telecom / Server SMPS
- UPS
- PV inverter
- PC Silverbox
- LED / OLED TV
- Motor Drives

4. Quick reference data

Table 1. Q	uick reference data						
Symbol	Parameter	Conditions	Values			Unit	
Absolute	maximum rating						
V_{RRM}	repetitive peak reverse voltage			12	200		V
I _{O(AV)}	limiting average forward current	δ = 0.5 ; square-wave pulse; T _{mb} ≤ 119 °C; both diodes conducting; Fig. 1; Fig. 2; Fig. 3	40		A		
T _j	junction temperature		·	175		°C	
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Static ch	aracteristics						
V _F	forward voltage	I _F = 20 A; T _j = 25 °C; per diode; <u>Fig. 5</u>		-	1.45	1.65	V
		$I_F = 20 \text{ A}; T_j = 150 \text{ °C}; \text{ per diode}; Fig. 5$		-	1.95	2.30	V
		$I_F = 20 \text{ A}; T_j = 175 \text{ °C}; \text{ per diode}; Fig. 5$		-	2.10	2.60	V
Dynamic	characteristics						
Q _r	recovered charge	$I_F = 20 \text{ A}; \text{ d}I_F/\text{d}t = 500 \text{ A}/\mu\text{s}; \text{ V}_R = 400 \text{ V};$ $T_j = 25 \text{ °C}; \text{ per diode}; Fig. 7$		-	44	-	nC



5. Pinning information

Table 2. F	Pinning infor	mation		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	A1	anode		
2	К	cathode		
3	A2	anode		К К
mb	mb	mounting base; connected to cathode		sym125

6. Ordering information

Table 3. Ordering information							
Type number	Package name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date	
WNSC2D401200CW	TO247	WNSC2D401200CW6Q	Tube	30	SOT429	25-Mar-2013	

7. Marking

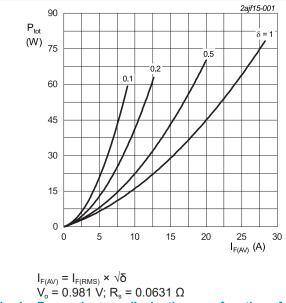
Table 4. Marking codes						
Type number	Marking codes					
WNSC2D401200CW	WNSC2D 401200CW					

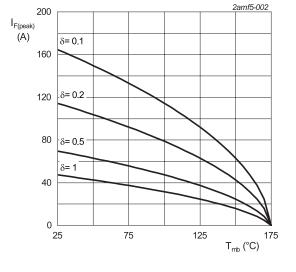
8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Values	Unit
V_{RRM}	repetitive peak reverse voltage		1200	V
V_{RWM}	crest working reverse voltage		1200	V
V _R	reverse voltage	DC	1200	V
I _{O(AV)}	limiting average forward current	$δ = 0.5$; square-wave pulse; $T_{mb} \le 119$ °C; both diodes conducting; <u>Fig. 1</u> ; <u>Fig. 2</u> ; <u>Fig. 3</u>	40	A
I _{FRM}	repetitive peak forward current	δ = 0.5; t _p = 25 μs; T _{mb} ≤ 119 °C; square-wave pulse; per diode	40	A
I _{FSM}	non-repetitive peak forward current	t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode	160	A
		t_p = 10 µs; $T_{j(init)}$ = 25 °C; square-wave pulse; per diode	1000	A
l ² t	l ² t for fusing	sine-wave pulse; $T_{j(init)}$ = 25 °C; t_p = 10 ms	128	A²s
T _{stg}	storage temperature		-55 to 175	°C
T _j	junction temperature		-55 to 175	°C



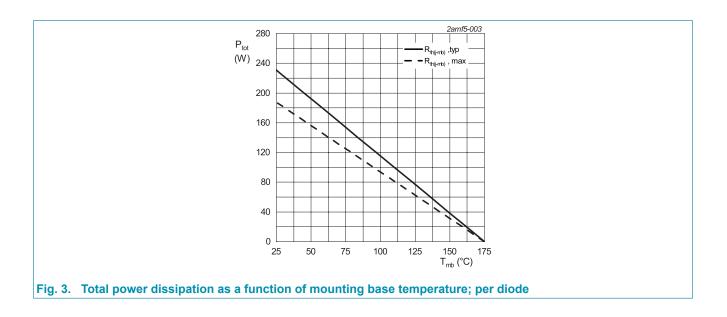




I_{F(AV)} = I_{F(RMS)} × √δ
V_o = 0.981 V; R_s = 0.0631 Ω
Fig. 1. Forward power dissipation as a function of average forward current; square waveform; maximum values; per diode

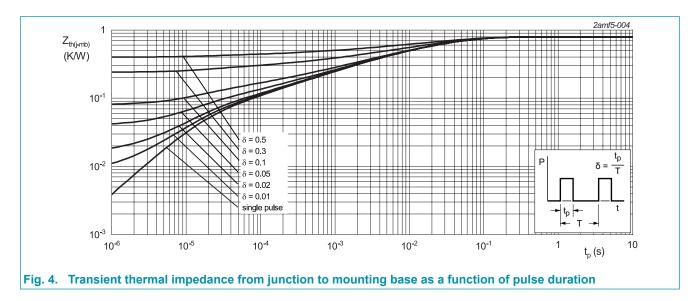
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WNSC2D401200CW Silicon Carbide Diode



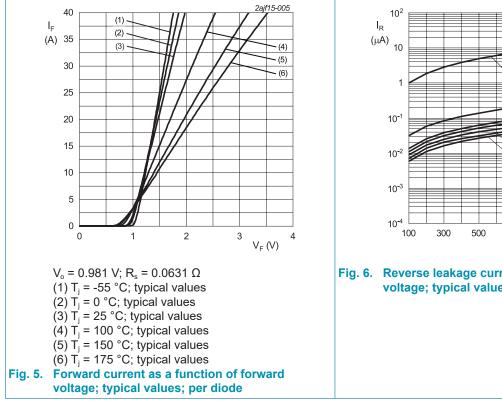
9. Thermal characteristics

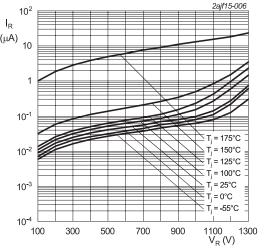
Table 6. Th	ermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{\text{th(j-mb)}}$	thermal resistance from junction to mounting base	per diode; <u>Fig. 4</u>	-	0.65	0.8	K/W
		both diodes conducting	-	0.31	0.4	K/W
R _{th(j-a)}	thermal resistance from junction to ambient free air	in free air	-	40	-	K/W



10. Characteristics

Table 7. C	haracteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _F	forward current	$I_{F} = 20 \text{ A}; T_{j} = 25 \text{ °C}; \text{ per diode}; Fig. 5$	-	1.45	1.65	V
		$I_F = 20 \text{ A}; T_j = 150 \text{ °C}; \text{ per diode}; Fig. 5$	-	1.95	2.30	V
		$I_F = 20 \text{ A}; T_j = 175 \text{ °C}; \text{ per diode}; Fig. 5$	-	2.10	2.60	V
I _R	reverse current	V_{R} = 1200 V; T _j = 25 °C; per diode; <u>Fig. 6</u>	-	1	100	μA
		V _R = 1200 V; T _j = 175 °C; per diode; <u>Fig. 6</u>	-	25	1000	μA
Dynamic	characteristics		· /			
Q _r	recovered charge	I _F = 20 A; V _R = 400 V; dI _F /dt = 500 A/μs; T _j = 25 °C; per diode; <u>Fig. 7</u>	-	44	-	nC
C _d	diode capacitance	f = 1 MHz; V_R = 1 V; T_j = 25 °C; per diode	-	927	-	pF
		f = 1 MHz; V_R = 400 V; T_j = 25 °C; per diode	-	84	-	pF
		f = 1 MHz; V_R = 800 V; T_j = 25 °C; per diode	-	63	-	pF
E _{as}	non-repetitive avalanche energy	I_R = 5.3 A; L = 10 mH; $T_{j(init)}$ = 25 °C; per diode	140	-	-	mJ

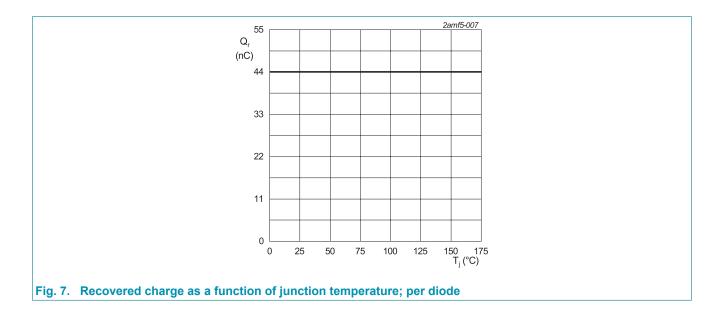






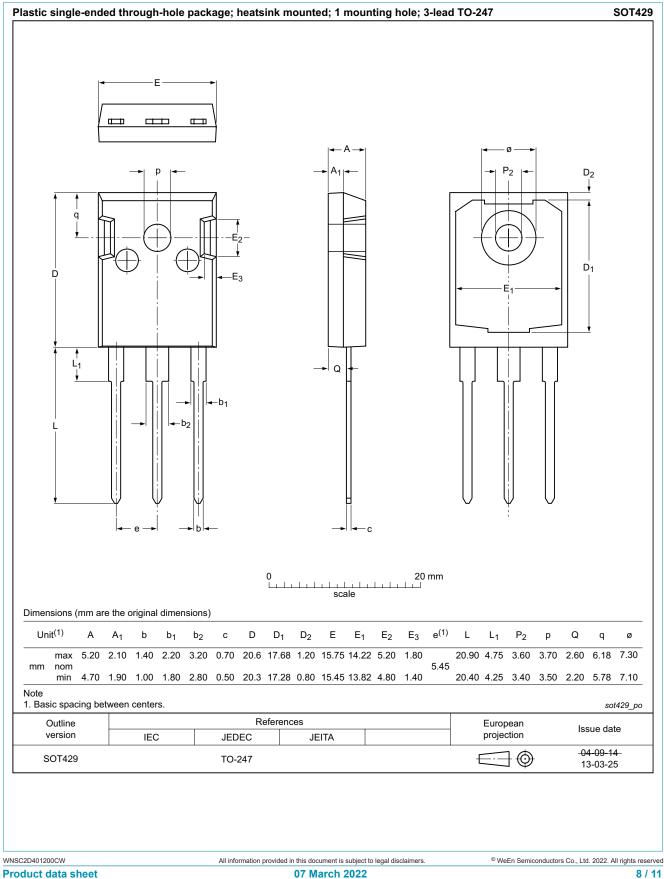
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11. Package outline



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12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

- [2] The term 'short data sheet' is explained in section "Definitions".
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